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Si4276DY-T1-E3
 Vishay Siliconix

Dual N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY				
	V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)
Channel 1	30	0.0153 at V _{GS} = 10 V	8 ^e	8.4
		0.0184 at V _{GS} = 4.5 V	8 ^e	
Channel 2	30	0.0280 at V _{GS} = 10 V	8	3.6
		0.0340 at V _{GS} = 4.5 V	7.1	

FEATURES

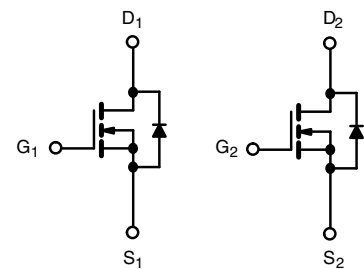
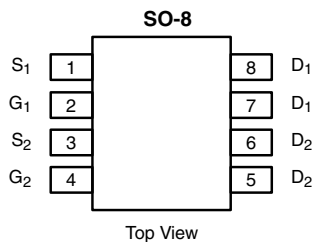
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC



RoHS
 COMPLIANT

APPLICATIONS

- DC/DC for Notebook PC



Ordering Information: Si4276DY-T1-E3 (Lead (Pb)-free)

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
Parameter	Symbol	Channel 1	Channel 2	Unit	
Drain-Source Voltage	V _{DS}	30		V	
Gate-Source Voltage	V _{GS}	± 20			
Continuous Drain Current (T _J = 150 °C)	I _D	T _C = 25 °C	8 ^e	8	A
		T _C = 70 °C	8 ^e	6.4	
		T _A = 25 °C	8 ^{b, c, e}	6.8 ^{b, c}	
		T _A = 70 °C	7.6 ^{b, c}	5.5 ^{b, c}	
Pulsed Drain Current (10 μs Pulse Width)	I _{DM}	50	30		
Source-Drain Current Diode Current	I _S	T _C = 25 °C	3.0	2.3	
		T _A = 25 °C	1.7 ^{b, c}	1.7 ^{b, c}	
Single Pulse Avalanche Current	I _{AS}	20	10		
Avalanche Energy	E _{AS}	20	5	mJ	
Maximum Power Dissipation	P _D	T _C = 25 °C	3.6	2.8	W
		T _C = 70 °C	2.3	1.8	
		T _A = 25 °C	2.1 ^{b, c}	2.0 ^{b, c}	
		T _A = 70 °C	1.3 ^{b, c}	1.3 ^{b, c}	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150		°C	

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Channel 1		Channel 2		Unit
		Typical	Maximum	Typical	Maximum	
Maximum Junction-to-Ambient ^{b, d}	R _{thJA}	47	60	58	62.5	°C/W
Maximum Junction-to-Foot (Drain)	R _{thJF}	30	35	38	45	

Notes:

- Based on T_C = 25 °C.
- Surface mounted on 1" x 1" FR4 board.
- t = 10 s.
- Maximum under steady state conditions is 107 °C/W (Ch 1) and 110 °C/W (Ch 2).
- Package limited.

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SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted)							
Parameter	Symbol	Test Conditions	Min.	Typ. ^a	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	Ch 1	30		V	
		$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	Ch 2	30			
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$	Ch 1		29	mV/ $^\circ\text{C}$	
		$I_D = 250\text{ }\mu\text{A}$	Ch 2		30		
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250\text{ }\mu\text{A}$	Ch 1		- 5.2		
		$I_D = 250\text{ }\mu\text{A}$	Ch 2		- 4.4		
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	Ch 1	1.2		V	
		$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	Ch 2	1.2			2.5
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$	Ch 1			100	
			Ch 2			100	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$	Ch 1			1	
		$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$	Ch 2			1	
		$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$	Ch 1			10	
		$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$	Ch 2			10	
On-State Drain Current ^b	$I_{D(on)}$	$V_{DS} = 5\text{ V}, V_{GS} = 10\text{ V}$	Ch 1	10		A	
		$V_{DS} = 5\text{ V}, V_{GS} = 10\text{ V}$	Ch 2	10			
Drain-Source On-State Resistance ^b	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 9.5\text{ A}$	Ch 1		0.0127	0.0153	
		$V_{GS} = 10\text{ V}, I_D = 6.8\text{ A}$	Ch 2		0.0230	0.0280	
		$V_{GS} = 4.5\text{ V}, I_D = 8.7\text{ A}$	Ch 1		0.0146	0.0184	
		$V_{GS} = 4.5\text{ V}, I_D = 6.1\text{ A}$	Ch 2		0.0280	0.0340	
Forward Transconductance ^b	g_{fs}	$V_{DS} = 15\text{ V}, I_D = 9.5\text{ A}$	Ch 1		43	S	
		$V_{DS} = 15\text{ V}, I_D = 6.8\text{ A}$	Ch 2		17		
Dynamic^a							
Input Capacitance	C_{iss}	Channel 1 $V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$ Channel 2 $V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	Ch 1		1000	pF	
			Ch 2		366		
Output Capacitance	C_{oss}		Ch 1		215		
			Ch 2		82		
Reverse Transfer Capacitance	C_{rss}		Ch 1		85		
			Ch 2		45		
Total Gate Charge	Q_g	$V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}, I_D = 9.5\text{ A}$	Ch 1		17.2	26	
		$V_{DS} = 15\text{ V}, V_{GS} = 10\text{ V}, I_D = 6.8\text{ A}$	Ch 2		7.3	15	
		Channel 1 $V_{DS} = 15\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 9.5\text{ A}$	Ch 1		8.4	17	
			Ch 2		3.6	8	
Gate-Source Charge	Q_{gs}	Channel 2 $V_{DS} = 15\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 6.8\text{ A}$	Ch 1		3	nC	
			Ch 2		1.1		
Gate-Drain Charge	Q_{gd}	Ch 1		2.6			
		Ch 2		1.3			
Gate Resistance	R_g	$f = 1\text{ MHz}$	Ch 1	0.6	3.1		6.2
			Ch 2	0.5	2.6		5.2


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SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted)							
Parameter	Symbol	Test Conditions	Min.	Typ. ^a	Max.	Unit	
Dynamic^a							
Turn-On Delay Time	$t_{d(on)}$	Channel 1 $V_{DD} = 15\text{ V}, R_L = 2\ \Omega$ $I_D \cong 7.6\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\ \Omega$ Channel 2 $V_{DD} = 15\text{ V}, R_L = 2.7\ \Omega$ $I_D \cong 5.5\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\ \Omega$ Channel 1 $V_{DD} = 15\text{ V}, R_L = 2\ \Omega$ $I_D \cong 7.6\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\ \Omega$ Channel 2 $V_{DD} = 15\text{ V}, R_L = 2.7\ \Omega$ $I_D \cong 5.5\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\ \Omega$	Ch 1		8	16	ns
			Ch 2		4	8	
Rise Time	t_r		Ch 1		10	20	
			Ch 2		8	16	
Turn-Off Delay Time	$t_{d(off)}$		Ch 1		20	30	
			Ch 2		11	20	
Fall Time	t_f		Ch 1		7	14	
			Ch 2		7	14	
Turn-On Delay Time	$t_{d(on)}$		Ch 1		14	21	
			Ch 2		8	16	
Rise Time	t_r	Ch 1		11	20		
		Ch 2		10	20		
Turn-Off Delay Time	$t_{d(off)}$	Ch 1		18	27		
		Ch 2		10	20		
Fall Time	t_f	Ch 1		7	14		
		Ch 2		7	14		
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I_S	$T_C = 25\text{ }^\circ\text{C}$	Ch 1			3	A
			Ch 2			2.3	
Pulse Diode Forward Current ^a	I_{SM}		Ch 1			50	A
			Ch 2			30	
Body Diode Voltage	V_{SD}	$I_S = 7.6\text{ A}$	Ch 1		0.82	1.2	V
			Ch 2		0.85	1.2	
Body Diode Reverse Recovery Time	t_{rr}		Ch 1		20	30	ns
			Ch 2		13	20	
Body Diode Reverse Recovery Charge	Q_{rr}	Channel 1 $I_F = 7.7\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$ Channel 2 $I_F = 5.5\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$	Ch 1		12	20	nC
			Ch 2		6	12	
Reverse Recovery Fall Time	t_a		Ch 1		11		ns
			Ch 2		7		
Reverse Recovery Rise Time	t_b		Ch 1		9		ns
			Ch 2		6		

Notes:

a. Guaranteed by design, not subject to production testing.

 b. Pulse test; pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$.

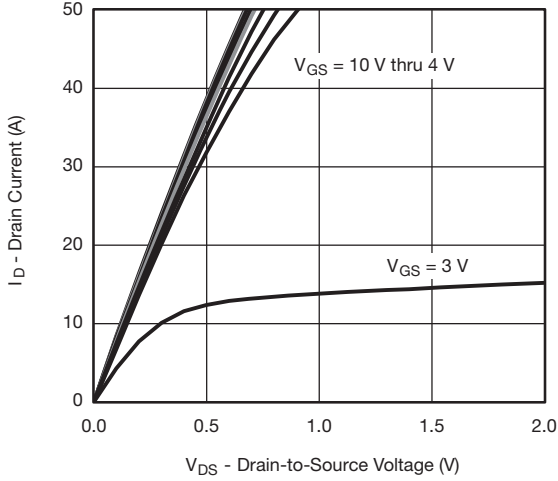
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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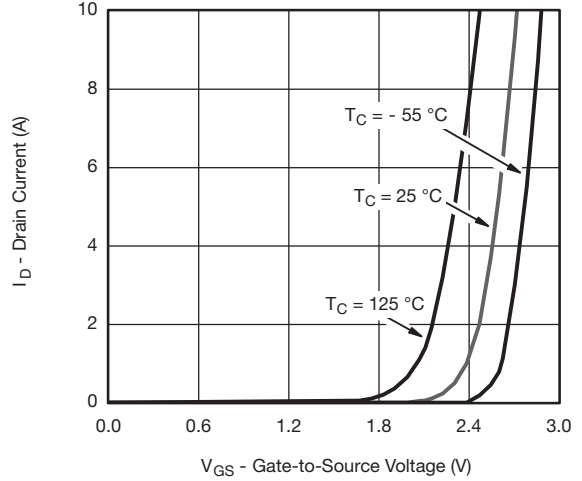
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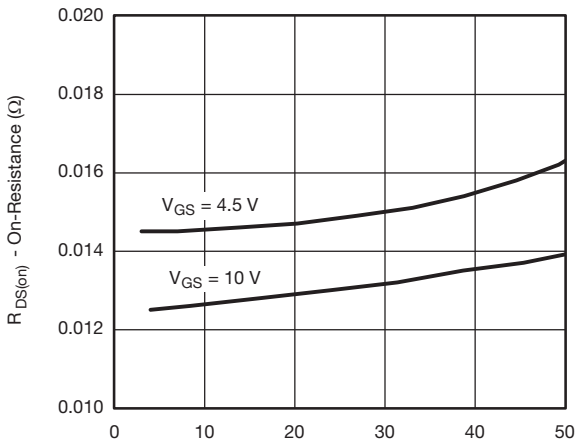
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



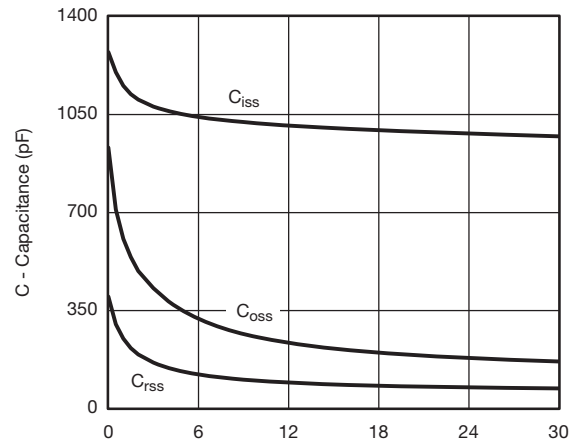
Output Characteristics



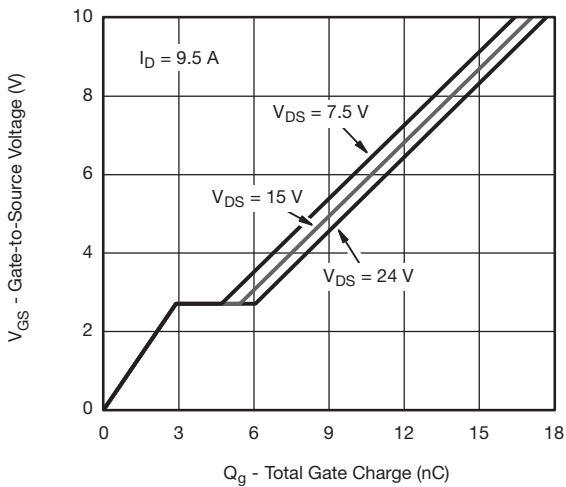
Transfer Characteristics



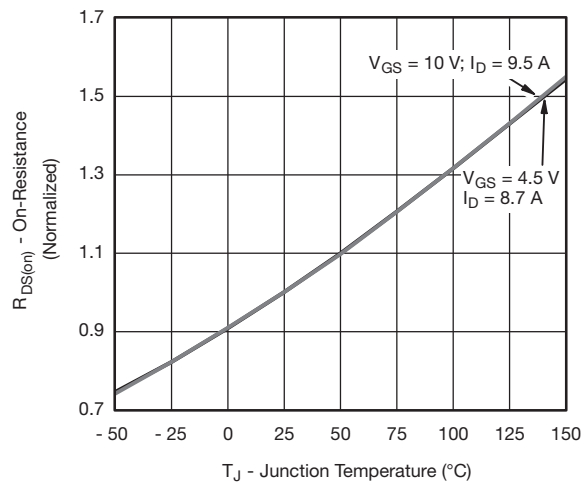
On-Resistance vs. Drain Current



Capacitance



Gate Charge

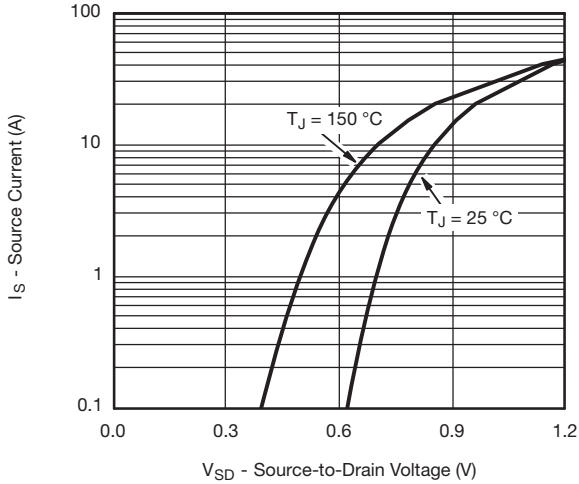


On-Resistance vs. Junction Temperature

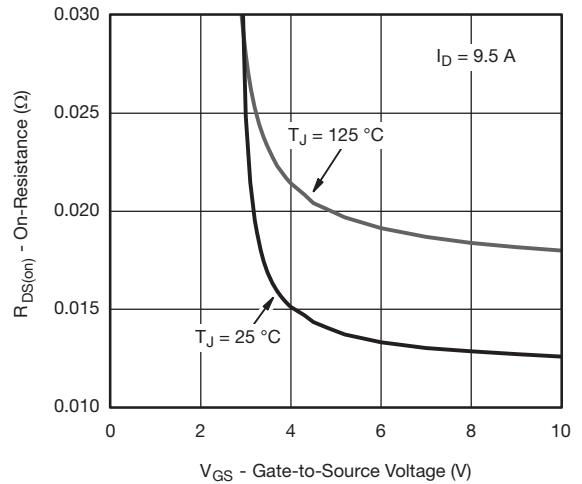


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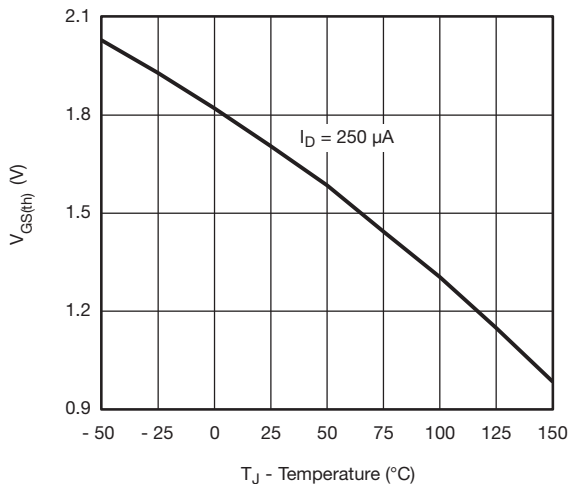
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



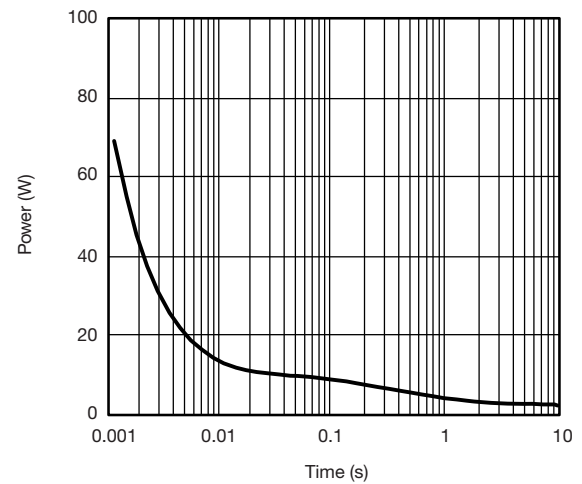
Source-Drain Diode Forward Voltage



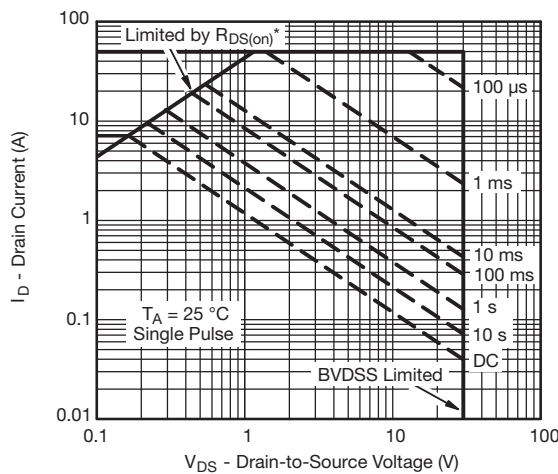
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient



* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

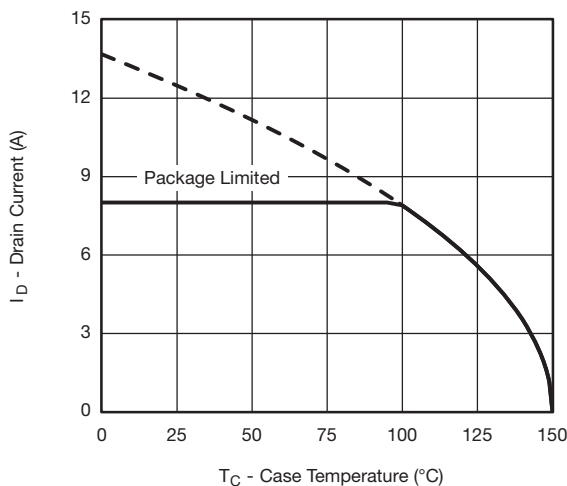
Safe Operating Area, Junction-to-Ambient

Si4276DY-T1-E3

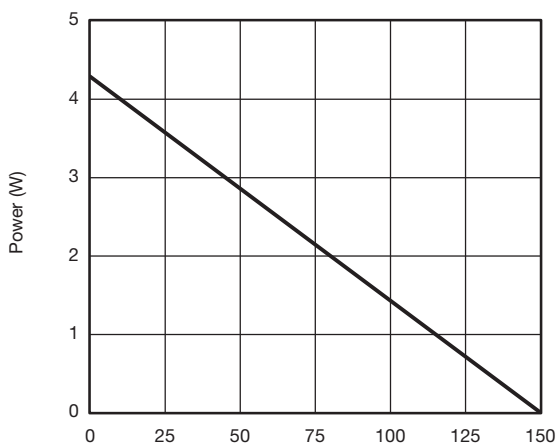
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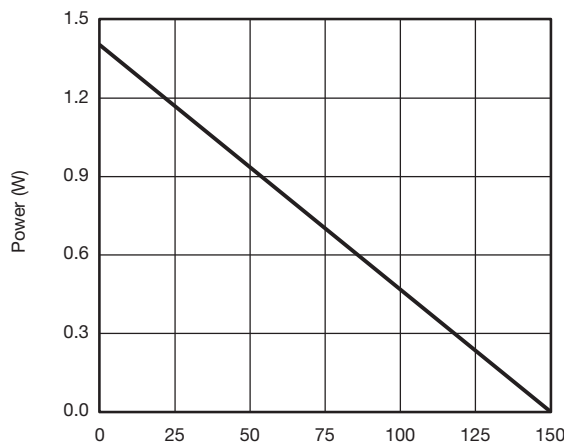
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*



Power Derating, Junction-to-Foot



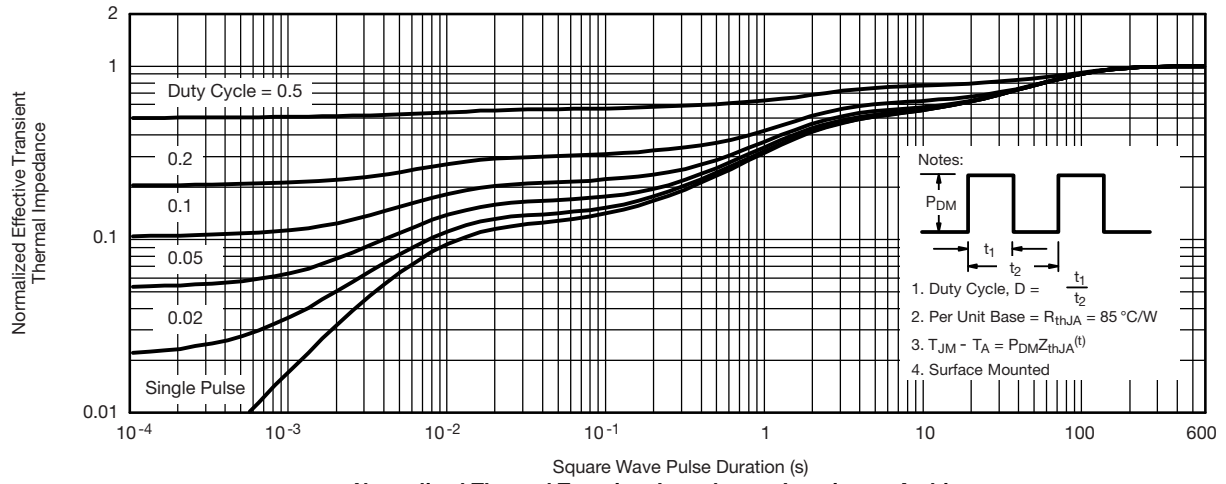
Power Derating, Junction-to-Ambient

* The power dissipation P_D is based on $T_{J(max)} = 150\text{ °C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

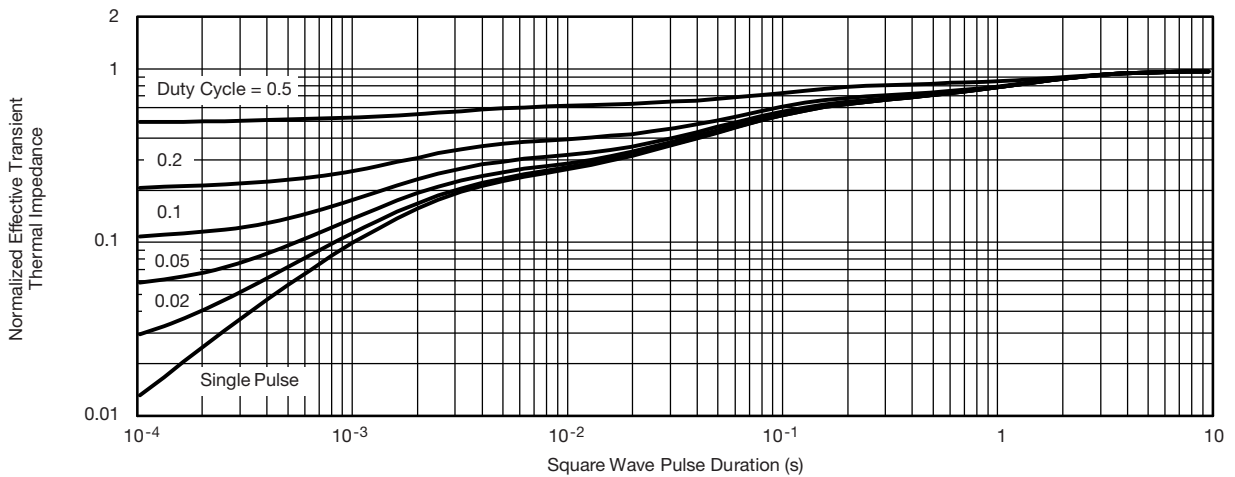


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CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



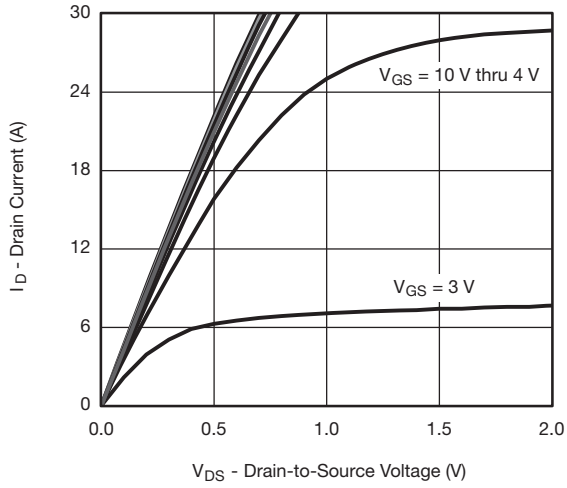
Normalized Thermal Transient Impedance, Junction-to-Foot

Si4276DY-T1-E3

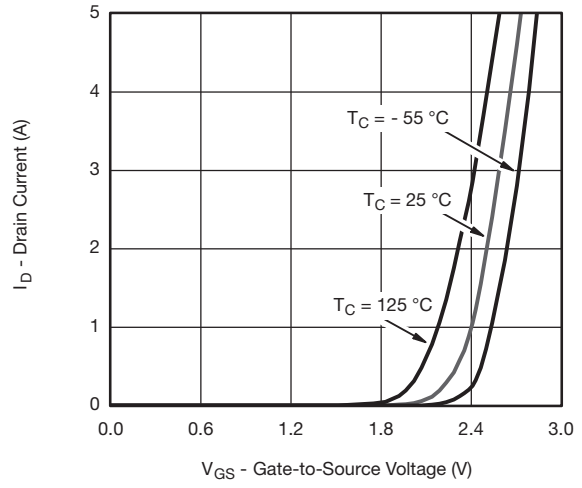
Vishay Siliconix



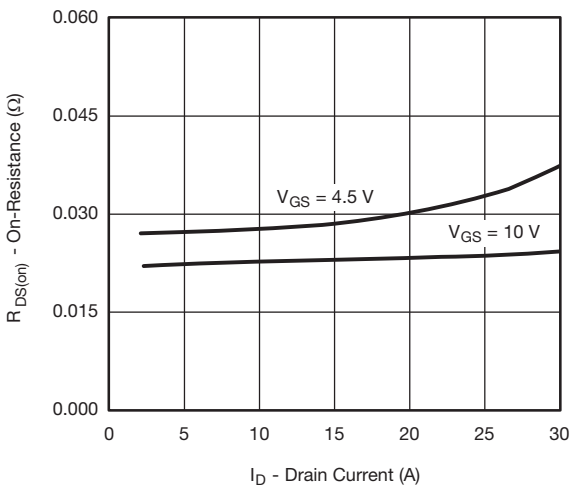
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



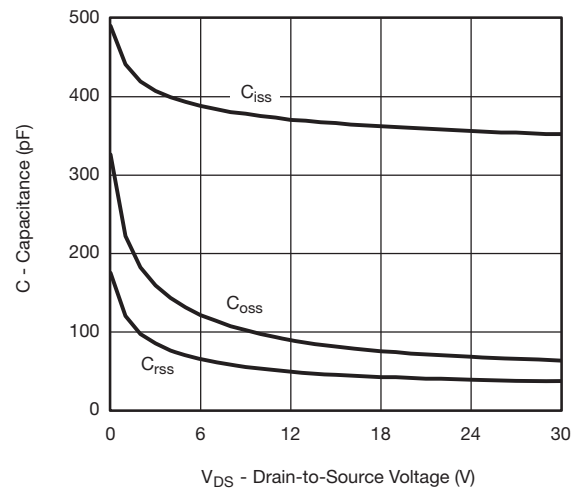
Output Characteristics



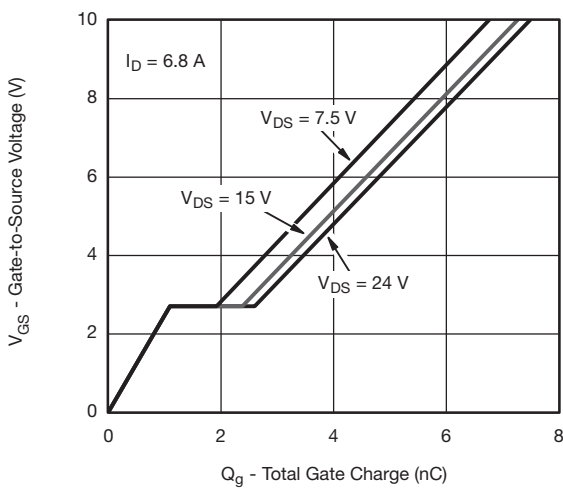
Transfer Characteristics



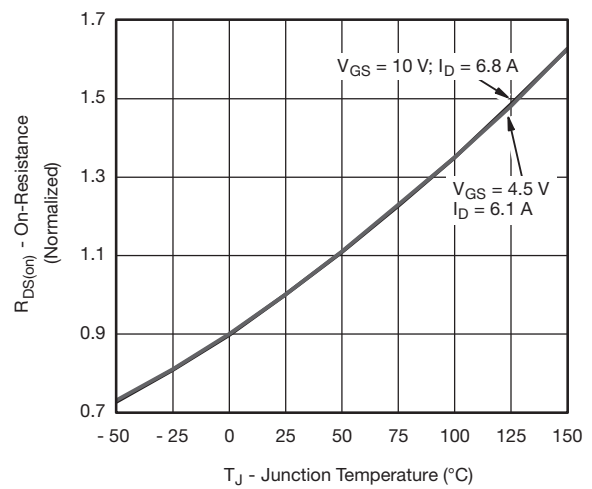
On-Resistance vs. Drain Current



Capacitance



Gate Charge

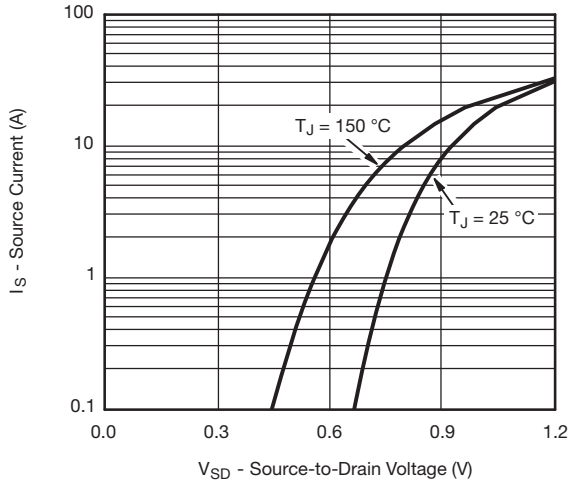


On-Resistance vs. Junction Temperature

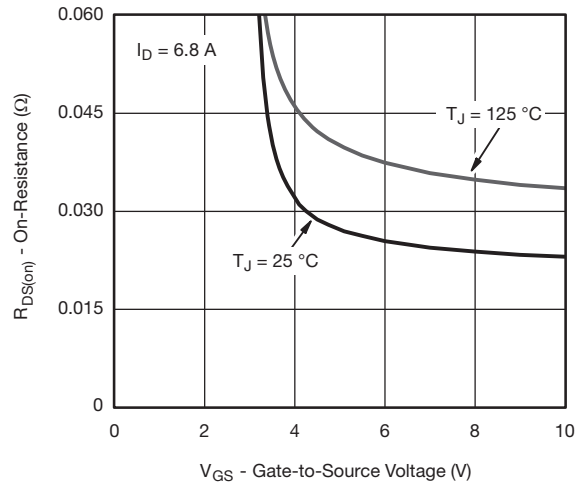


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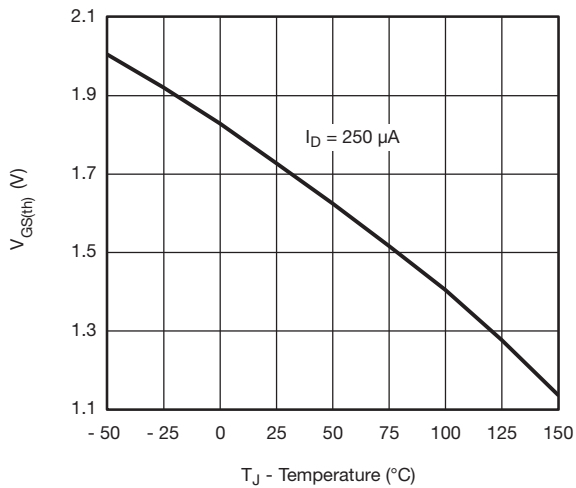
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



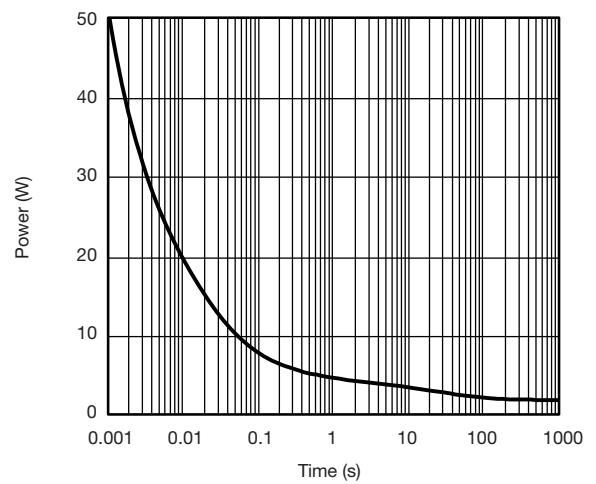
Source-Drain Diode Forward Voltage



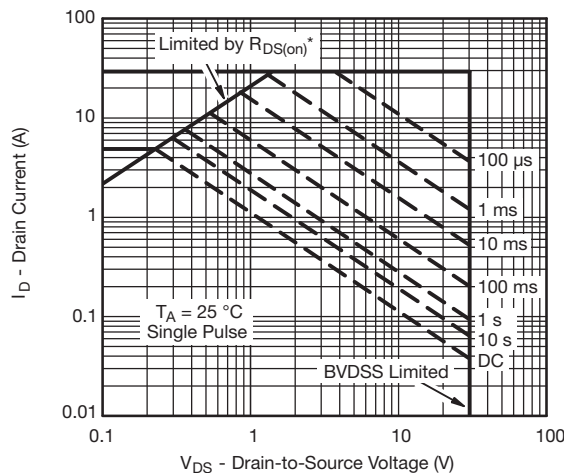
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient



* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

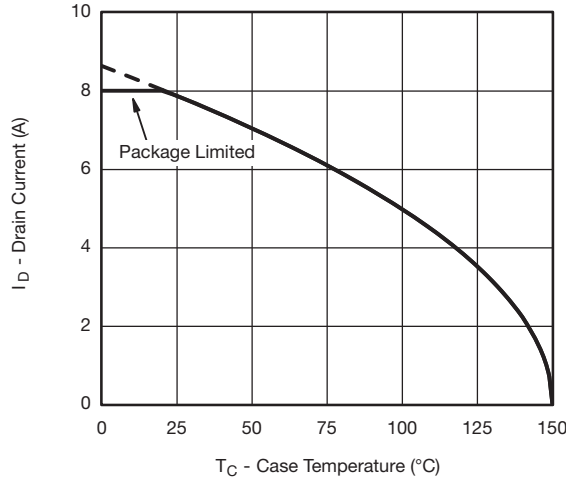
Safe Operating Area, Junction-to-Ambient

Si4276DY-T1-E3

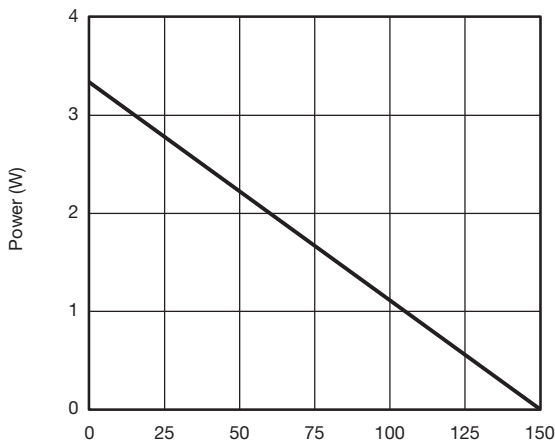
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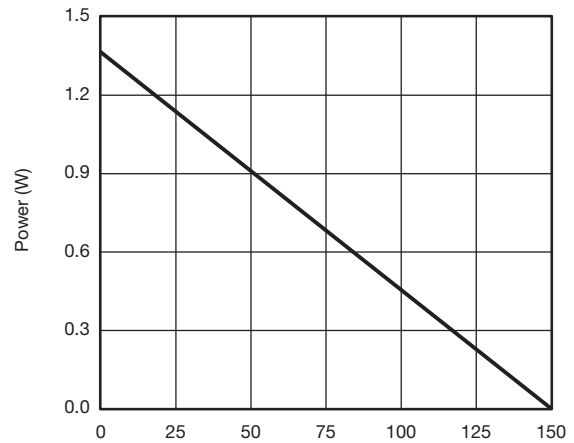
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*



Power Derating, Junction-to-Foot



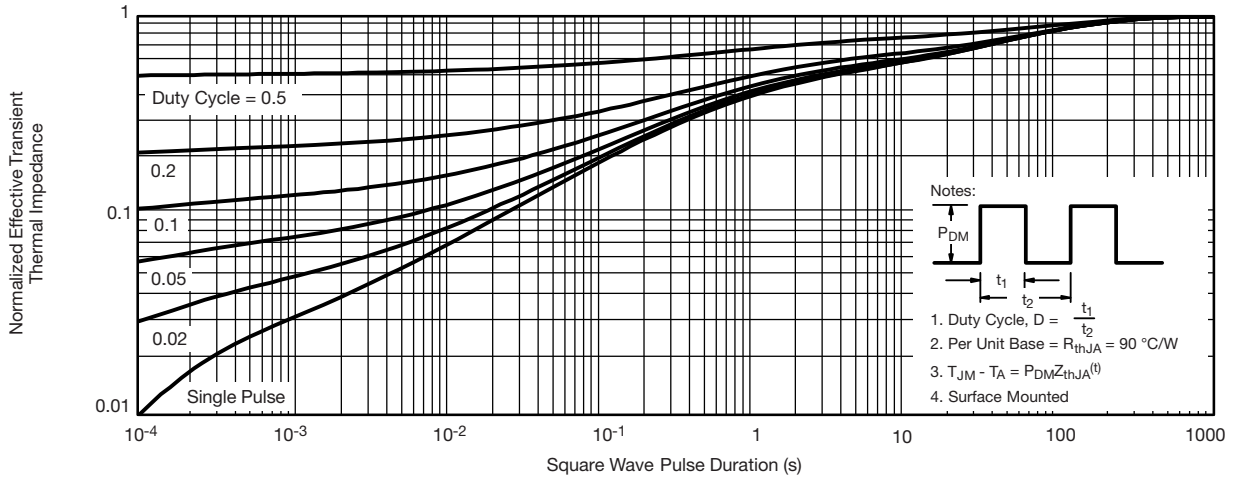
Power Derating, Junction-to-Ambient

* The power dissipation P_D is based on $T_{J(max)} = 150\text{ °C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

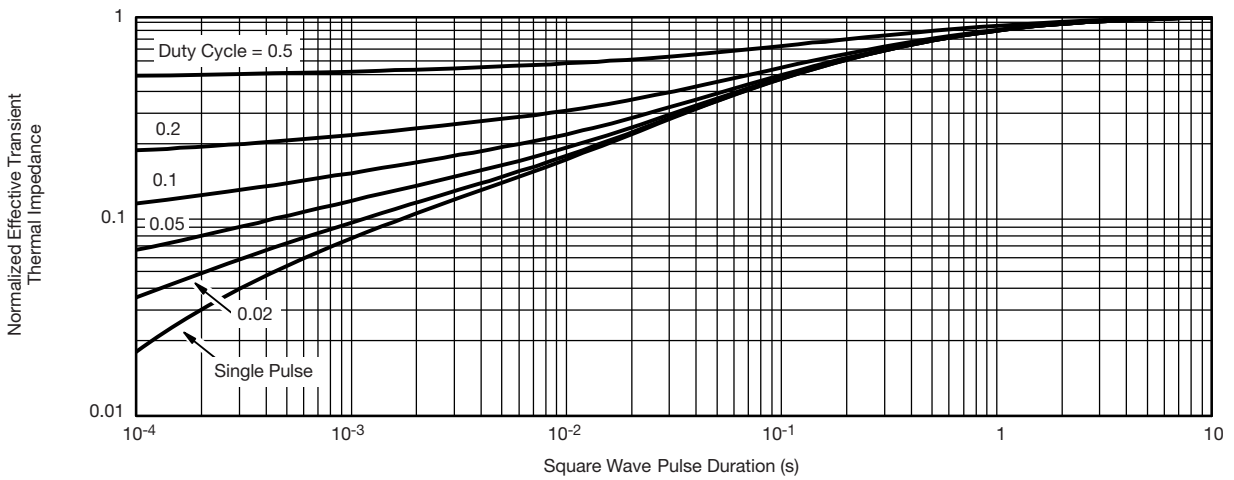


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CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations.

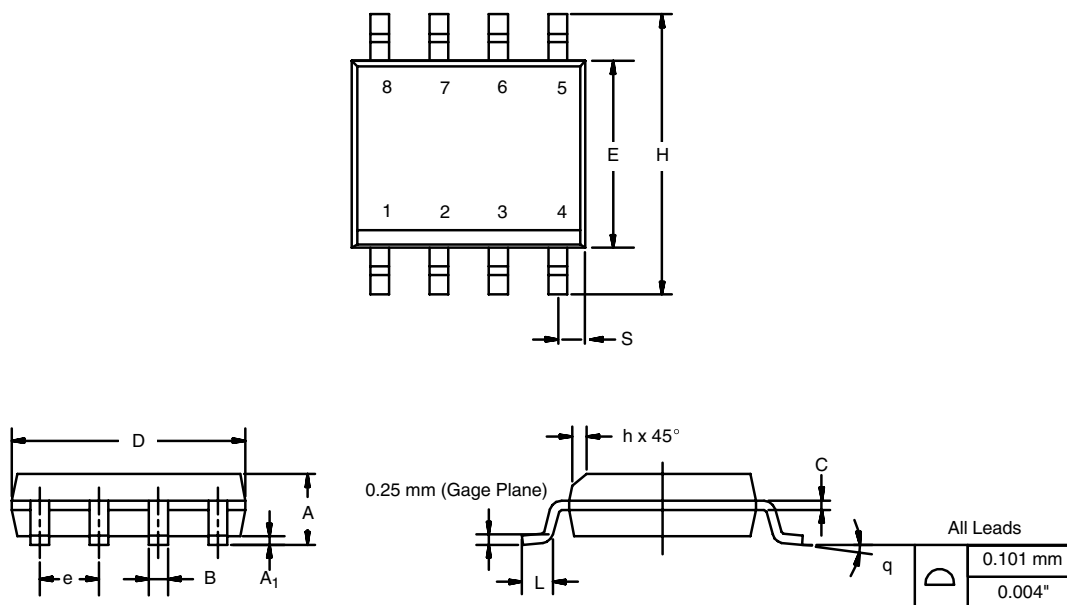


Package Information

Vishay Siliconix

SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012



DIM	MILLIMETERS		INCHES	
	Min	Max	Min	Max
A	1.35	1.75	0.053	0.069
A ₁	0.10	0.20	0.004	0.008
B	0.35	0.51	0.014	0.020
C	0.19	0.25	0.0075	0.010
D	4.80	5.00	0.189	0.196
E	3.80	4.00	0.150	0.157
e	1.27 BSC		0.050 BSC	
H	5.80	6.20	0.228	0.244
h	0.25	0.50	0.010	0.020
L	0.50	0.93	0.020	0.037
q	0°	8°	0°	8°
S	0.44	0.64	0.018	0.026

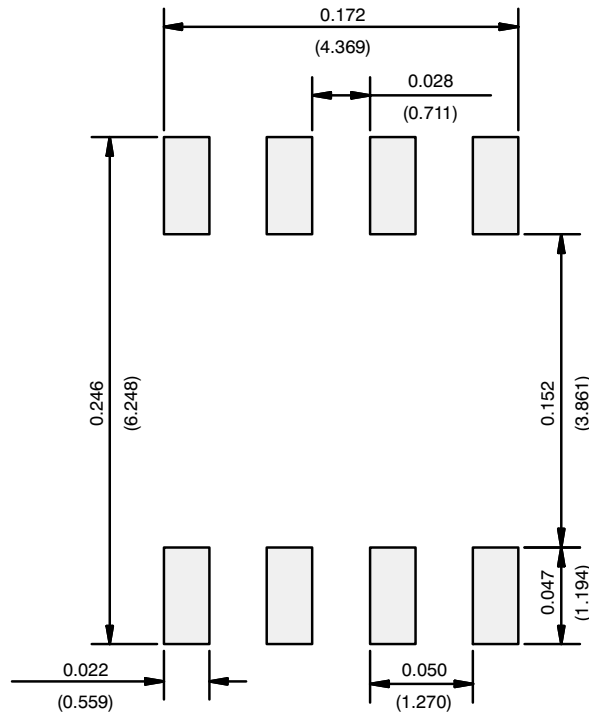
ECN: C-06527-Rev. I, 11-Sep-06
DWG: 5498

Application Note 826

Vishay Siliconix



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads
 Dimensions in Inches/(mm)

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